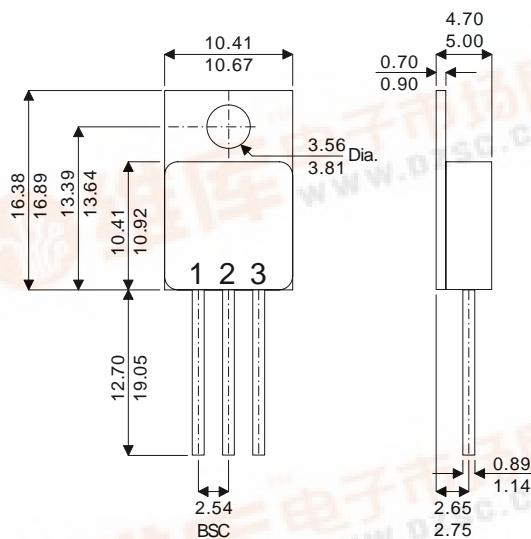


IRFY440

MECHANICAL DATA

Dimensions in mm (inches)

**TO-220M – Metal Package**

Pad 1 – Gate

Pad 2 – Drain

Pad 3 – Source

**N-CHANNEL
POWER MOSFET
FOR HI-REL
APPLICATIONS**

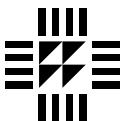
V_{DSS}	500V
$I_{D(\text{cont})}$	5.5A
$R_{DS(\text{on})}$	0.85Ω

FEATURES

- HERMETICALLY SEALED TO-220 METAL PACKAGE
- SIMPLE DRIVE REQUIREMENTS
- LIGHTWEIGHT
- SCREENING OPTIONS AVAILABLE
- ALL LEADS ISOLATED FROM CASE

ABSOLUTE MAXIMUM RATINGS ($T_{\text{case}} = 25^{\circ}\text{C}$ unless otherwise stated)

V_{GS}	Gate – Source Voltage	±20V
I_D	Continuous Drain Current @ $T_{\text{case}} = 25^{\circ}\text{C}$	5.5A
I_D	Continuous Drain Current @ $T_{\text{case}} = 100^{\circ}\text{C}$	3.5A
I_{DM}	Pulsed Drain Current	22A
P_D	Power Dissipation @ $T_{\text{case}} = 25^{\circ}\text{C}$	60W
	Linear Derating Factor	0.48W/°C
T_J, T_{stg}	Operating and Storage Temperature Range	-55 to 150°C
	Thermal Resistance Junction to Case	2.1°C/W max.
	Thermal Resistance Junction to Ambient	80°C/W max.



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IRFY440

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
STATIC ELECTRICAL RATINGS					
BV_{DSS}	Drain – Source Breakdown Voltage $V_{\text{GS}} = 0$ $I_D = 1\text{mA}$	500			V
$\Delta \text{BV}_{\text{DSS}}$	Temperature Coefficient of Breakdown Voltage	Reference to 25°C $I_D = 1\text{mA}$		0.78	$\text{V}/^\circ\text{C}$
$R_{\text{DS}(\text{on})}$	Static Drain – Source On-State Resistance	$V_{\text{GS}} = 10\text{V}$ $I_D = 3.5\text{A}$		0.85	Ω
		$V_{\text{GS}} = 10\text{V}$ $I_D = 5.5\text{A}$		0.98	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage $V_{\text{DS}} = V_{\text{GS}}$	$I_D = 250\mu\text{A}$	2	4	V
g_{fs}	Forward Transconductance $V_{\text{DS}} \geq 15\text{V}$	$I_{\text{DS}} = 3.5\text{A}$	4.7		$\text{S}(\text{O})$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{GS}} = 0$ $V_{\text{DS}} = 0.8\text{BV}_{\text{DSS}}$		25	μA
		$T_J = 125^\circ\text{C}$		250	
I_{GSS}	Forward Gate – Source Leakage $V_{\text{GS}} = 20\text{V}$			100	nA
I_{GSS}	Reverse Gate – Source Leakage $V_{\text{GS}} = -20\text{V}$			-100	
DYNAMIC CHARACTERISTICS					
C_{iss}	Input Capacitance $V_{\text{GS}} = 0$		1300		pF
C_{oss}	Output Capacitance $V_{\text{DS}} = 25\text{V}$		310		
C_{rss}	Reverse Transfer Capacitance $f = 1\text{MHz}$		120		
Q_g	Total Gate Charge $V_{\text{GS}} = 10\text{V}$ $I_D = 5.5\text{A}$ $V_{\text{DS}} = 0.5\text{BV}_{\text{DSS}}$	27.3		68.5	nC
Q_{gs}	Gate – Source Charge $I_D = 5.5\text{A}$	2		12.5	nC
Q_{gd}	Gate – Drain ("Miller") Charge $V_{\text{DS}} = 0.5\text{BV}_{\text{DSS}}$	11.1		42.4	
$t_{\text{d}(\text{on})}$	Turn-On Delay Time			21	ns
t_r	Rise Time			73	
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time			72	
t_f	Fall Time			51	
SOURCE – DRAIN DIODE CHARACTERISTICS					
I_s	Continuous Source Current			5.5	A
I_{SM}	Pulse Source Current			22	
V_{SD}	Diode Forward Voltage $I_S = 5.5\text{A}$ $T_J = 25^\circ\text{C}$ $V_{\text{GS}} = 0$			1.5	V
t_{rr}	Reverse Recovery Time $I_S = 5.5\text{A}$ $T_J = 25^\circ\text{C}$			700	ns
Q_{rr}	Reverse Recovery Charge $d_i / d_t \leq 100\text{A}/\mu\text{s}$ $V_{\text{DD}} \leq 50\text{V}$			8.9	μC
PACKAGE CHARACTERISTICS					
L_D	Internal Drain Inductance (from 6mm down drain lead pad to centre of die)		8.7		nH
L_S	Internal Source Inductance (from 6mm down source lead to centre of source bond pad)		8.7		